Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/815,106	ICHIKAWA ET AL.	
Examiner	Art Unit	
Shin-Hon Chen	2131	

SEARCHED					
Class	Subclass	Date	Examiner		
713	158,168	6/8/2007	S.C.		
713	169,170	6/8/2007	S.C.		
713	156	6/8/2007	S.C.		
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOT (INCLUDING SEARCH :	ES STRATEGY)	)
	DATE	EXMR
USPAT, PGPUB, DERWENT, JPO, EPO (BRS search- see search history)	6/8/2007	S.C.
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